Notice of R ferenc s Cited

	Application/Control No.		Applicant(s)/Patent Under Reexamination JOHN ET AL.		
	Examiner	Art Unit			
	A. Sefer	2826	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,133,591	10-2000	Letavic et al	257/139
	В	US-5,990,516	11-1999	Momose et al	257/327
	С	US-6,160,290	12-2000	Pendharkar et al	257/339
	D	US-5,969,387	10-1999	Letavic et al	257/347
	Е	US-5,834,823	11-1998	Honda	257/488
	F	US-6,365,932	04-2002	Kouno et al	357/341
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-260883	09-2000	Japan	Kamei et al	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.